TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

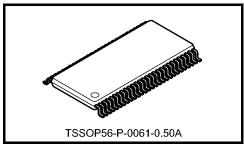
TC74VCX162827FT

Low-Voltage 20-Bit Bus Buffer with 3.6-V Tolerant Inputs and Outputs

The TC74VCX162827FT is a high-performance CMOS 20-bit bus buffer. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to 3.6 V.

The TC74VCX162827FT is composed of two 10-bit sections with separate output-enable signals. For either 10-bit buffer section, the two output-enable ($1\overline{OE1}$ and $1\overline{OE2}$ or $2\overline{OE1}$ and $2\overline{OE2}$) inputs must both be low for the corresponding Y outputs to be active. When the \overline{OE} input is high, the outputs are in a high-impedance state. This device is designed to be used with 3-state memory address drivers, etc.



Weight: 0.25 g (typ.)

The 26- Ω series resistor helps reducing output overshoot and undershoot without external resistor. All inputs are equipped with protection circuits against static discharge.

Features

- $26-\Omega$ series resistors on outputs
- Low-voltage operation: $V_{CC} = 1.8$ to 3.6 V
- High-speed operation: $t_{pd} = 3.4 \text{ (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$
 - $: t_{pd} = 4.1 \text{ (max)} (V_{CC} = 2.3 \text{ to } 2.7 \text{ V})$

$$t_{pd} = 8.2 \text{ (max)} (V_{CC} = 1.8 \text{ V})$$

• Output current: $I_{OH}/I_{OL} = \pm 12 \text{ mA} \text{ (min)} (V_{CC} = 3.0 \text{ V})$

: $I_{OH}/I_{OL} = \pm 8 \text{ mA} \text{ (min)} (V_{CC} = 2.3 \text{ V})$

 $: I_{OH}/I_{OL} = \pm 4 \text{ mA (min)} (V_{CC} = 1.8 \text{ V})$

- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200 \text{ V}$
 - Human body model $\ge \pm 2000 \text{ V}$
- Package: TSSOP
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs

Pin Assignment (top view)

56 10E2 10E1 1 1Y1 2 55 1A1 1Y2 3 54 1A2 GND 4 GND 53 1Y3 5 52 1A3 6 1Y4 51 1A4 7 V_{CC} 50 V_{CC} 1Y5 8 49 1A5 1Y6 9 48 1A6 1Y7 10 47 1A7 GND 11 GND 46 1Y8 12 1A8 45 1Y9 13 1A9 44 1Y10 14 1A10 43 2Y1 15 42 2A1 2Y2 16 2A2 41 2Y3 2A3 17 40 GND 18 GND 39 2Y4 19 2A4 38 2Y5 20 2A5 37 2Y6 21 2A6 36 V_{CC} 22 35 V_{CC} 2Y7 23 34 2A7 2Y8 24 2A8 33 GND 25 GND 32 2Y9 26 31 2A9 2Y10 27 2A10 30 20E1 28 $2\overline{OE2}$ 29

10E1 - 10E2 -	1 <u>56</u> 28	&	EN1		
2 0E1 — 2 0E2 —	29	&	EN2		
1A1 —	55		1 1 7	2	1Y1
1A2 —	54			3	1Y2
1A3 –	52			5	1Y3
1A3 –	51			6	1Y4
1A5 —	49			8	1Y5
1A6 –	48			9	1Y6
1A7 –	47			10	1Y7
1A8 —	45			12	1Y8
1A9 –	44			13	1Y9
1A10 -	43			14	1Y10
2A1 -	42		1 2 🗸	15	2Y1
2A1 2A2 —	41		1 2 V	16	2Y2
2A2 -	40			17	2Y3
2A3 2A4	38			19	213 2Y4
2A4	37			20	2Y5
	36			21	215 2Y6
2A6 2A7	34]		23	210 2Y7
2A7	33]		24	
	31			26	2Y8
2A9 -	30			27	2Y9
2A10 -					2Y10

IEC Logic Symbol

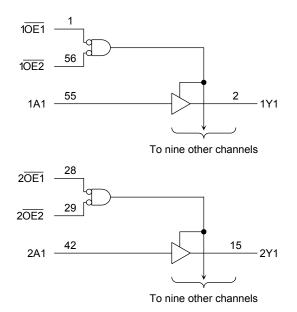
Truth Table (each 10-bit latch)

	Outputs		
OE1	OE2	А	Y
L	L	L	L
L	L	Н	н
Н	Х	Х	Z
Х	Н	х	Z

X: Don't care

Z: High impedance

System Diagram



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	-0.5 to 4.6	V
DC input voltage	V _{IN}	-0.5 to 4.6	V
		-0.5 to 4.6 (Note 2)	
DC output voltage	VOUT	–0.5 to V _{CC} + 0.5	V
		(Note 3)	
Input diode current	I _{IK}	-50	mA
Output diode current	I _{OK}	±50 (Note 4)	mA
DC output current	IOUT	±50	mA
Power dissipation	PD	400	mW
DC V_{CC} /ground current per supply pin	I _{CC} /I _{GND}	±100	mA
Storage temperature	T _{stg}	–65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 2: OFF state
- Note 3: High or low state. IOUT absolute maximum rating must be observed.
- Note 4: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	1.8 to 3.6	V
Tower suppry voltage	VCC	1.2 to 3.6 (Note 2)	v
Input voltage	V _{IN}	-0.3 to 3.6	V
Output voltage	Vout	0 to 3.6 (Note 3)	V
Ouput voltage	V001	0 to V _{CC} (Note 4)	v
		±12 (Note 5)	
Output current	IOH/IOL	±8 (Note 6)	mA
		±4 (Note 7)	
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Note 2: Data retention only

- Note 3: OFF state
- Note 4: High or low state
- Note 5: $V_{CC} = 3.0$ to 3.6 V
- Note 6: $V_{CC} = 2.3$ to 2.7 V
- Note 7: $V_{CC} = 1.8 V$
- Note 8: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V

Electrical Characteristics

DC Characteristics (Ta = –40 to 85°C, 2.7 V < V_{CC} \leq 3.6 V)

Characte	ristics	Symbol	Test	Condition		Min	Мах	Unit
Characteristics		Symbol	ol Test Condition		V _{CC} (V)	IVIIII	IVIAX	Unit
Input voltage	H-level	VIH		—	2.7 to 3.6	2.0		v
input voltage	L-level	VIL		_	2.7 to 3.6		0.8	v
				I _{OH} = -100 μA	2.7 to 3.6	V _{CC} - 0.2	_	
	H-level	V _{OH}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -6 \text{ mA}$	2.7	2.2		
		_		$I_{OH} = -8 \text{ mA}$	3.0	2.4	_	
Output voltage				$I_{OH} = -12 \text{ mA}$	3.0	2.2	_	V
		L-level V _{OL}		I _{OL} = 100 μA	2.7 to 3.6	_	0.2	
				I _{OL} = 6 mA	2.7	_	0.4	
	L-level		V_{OL} $V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 8 mA	3.0	_	0.55	
				I _{OL} = 12 mA	3.0	_	0.8	
Input leakage curr	ent	l _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	_	±5.0	μA
3-state output OFF state current I_{OZ} $V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		2.7 to 3.6		±10.0	μA	
Power-off leakage	current	IOFF	V _{IN} , V _{OUT} = 0 to 3.6 V		0		10.0	μA
.			V _{IN} = V _{CC} or GND		2.7 to 3.6		20.0	
Quiescent supply	current	ICC	$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3$	3.6 V	2.7 to 3.6		±20.0	μA
Increase in I _{CC} pe	er input	ΔI_{CC}	$V_{IH} = V_{CC} - 0.6 \ V$		2.7 to 3.6		750	

DC Characteristics (Ta = -40 to 85°C, 2.3 V \leq V_{CC} \leq 2.7 V)

Character	istics	Symbol	Test C	ondition	V _{CC} (V)	Min	Max	Unit
Input voltage	H-level	VIH	-	_	2.3 to 2.7	1.6	_	V
Input voltage	L-level	VIL	-		2.3 to 2.7	_	0.7	v
				I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2	_	
	H-level	Vон	V _{IN} = V _{IH} or V _{IL}	$I_{OH} = -4 \text{ mA}$	2.3	2.0	_	
				$I_{OH} = -6 \text{ mA}$	2.3	1.8	_	v
Output voltage				I _{OH} = -8 mA	2.3	1.7	_	
			$V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 100 μA	2.3 to 2.7	_	0.2	
	L-level	el V _{OL} V _{IN}		$I_{OL} = 6 \text{ mA}$	2.3	_	0.4	
				I _{OL} = 8 mA	2.3	_	0.6	
Input leakage curre	ent	I _{IN}	V _{IN} = 0 to 3.6 V		2.3 to 2.7	_	±5.0	μA
	atata aurrant	1	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$V_{IN} = V_{IH} \text{ or } V_{IL}$		_	±10.0	۸
S-State Output OFF	3-state output OFF state current	loz	V _{OUT} = 0 to 3.6 V		2.3 to 2.7		±10.0	μA
Power-off leakage	current	IOFF	V _{IN} , V _{OUT} = 0 to 3.6 V		0	_	10.0	μA
Quiescent supply of	urrent	loo	$V_{IN} = V_{CC}$ or GND		2.3 to 2.7	_	20.0	
		Icc	$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.0$	6 V	2.3 to 2.7	_	±20.0	μA

DC Characteristics (Ta = -40 to 85°C, 1.8 V \leq V_{CC} < 2.3 V)

Characteris	etice	Symbol				Min	Мах	Unit
Characteria	5005	Symbol			V _{CC} (V)	IVIIII	Max	Unit
Input voltage	H-level	VIH	-	_	1.8 to 2.3	$0.7 \times V_{CC}$	_	V
mput voltage	L-level	V _{IL}	-		1.8 to 2.3	_	$0.2 \times V_{CC}$	v
	H-level	el V_{OH} $V_{IN} = V_{IH} \text{ or } V_{IL}$ el V_{OL} $V_{IN} = V_{IH} \text{ or } V_{IL}$ $I_{OL} = 100$	I _{OH} = -100 μA	1.8	V _{CC} - 0.2	_		
Output voltage				$I_{OH} = -4 \text{ mA}$	1.8	1.4	_	V
	L-level			$I_{OL} = 100 \ \mu A$	1.8	_	0.2	
	L-IEVEI			$I_{OL} = 4 \text{ mA}$	1.8		0.3	
Input leakage curren	nt	I _{IN}	$V_{IN} = 0$ to 3.6 V		1.8		±5.0	μA
3-state output OFF state current I_{OZ} $V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$			1.8		±10.0	μA		
Power-off leakage of	urrent	I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	_	10.0	μA
Quiescent supply o	urrent	Icc	$V_{IN} = V_{CC} \text{ or } GND$	V _{IN} = V _{CC} or GND		_	20.0	μA
Quiescent supply ct	Quiescent supply current		$V_{CC} \leqq (V_{IN}, V_{OUT}) \leqq 3.6 \text{ V}$		1.8	_	±20.0	μA

AC Characteristics (Ta = -40 to 85°C, input: $t_r = t_f = 2.0 \text{ ns}$, $C_L = 30 \text{ pF}$, $R_L = 500 \Omega$) (Note 1)

Characteristics	Symbol	/mbol Test Condition		Min	Max	Unit
Characteristics	Symbol		V _{CC} (V)	IVIIII	Ινίαλ	Unit
	t		1.8	1.5	8.2	
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	1.0	4.1	ns
	^t pHL		$\textbf{3.3}\pm\textbf{0.3}$	0.8	3.4	
	t		1.8	1.5	9.8	
3-state output enable time	t _{pZL} t _{pZH}	Figure 1, Figure 3	2.5 ± 0.2	1.0	5.9	ns
			$\textbf{3.3}\pm\textbf{0.3}$	0.8	4.3	
	t . –		1.8	1.5	8.8	
3-state output disable time	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	2.5 ± 0.2	1.0	4.9	ns
			$\textbf{3.3}\pm\textbf{0.3}$	0.8	4.3	
	+		1.8	_	0.5	
Output to output skew	t _{osLH}	(Note 2)	2.5 ± 0.2		0.5	ns
	t _{osHL}		3.3 ± 0.3	_	0.5	

Note 1: For $C_L = 50 \text{ pF}$, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design. $(t_{osLH} = |t_{pLHm} - t_{pLHn}|, \ t_{osHL} = |t_{pHLm} - t_{pHLn}|)$

Dynamic Switching Characteristics

(Ta = 25°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500 \Omega$)

Characteristics	Symbol	Test Condition	,	V _{CC} (V)	Тур.	Unit
		VIH = 1.8 V. VII = 0 V ((Note)	1.8	0.15	
Quiet output maximum		V H = 1.8 V, V L = 0 V ((NOLE)	1.0	0.15	
dynamic V _{OL}	VOLP	$V_{IH} = 2.5 V, V_{IL} = 0 V$ ((Note)	2.5	0.25	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ ((Note)	3.3	0.35	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ ((Note)	1.8	-0.15	
Quiet output minimum dynamic V _{OI}	V _{OLV}	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ ((Note)	2.5	-0.25	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ ((Note)	3.3	-0.35	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ ((Note)	1.8	1.55	
Quiet output minimum dynamic V _{OH}	V _{OHV}	$V_{IH} = 2.5 V, V_{IL} = 0 V$ ((Note)	2.5	2.05	V
		$V_{IH} = 3.3 V, V_{IL} = 0 V$ ((Note)	3.3	2.65	

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition			Тур.	Unit
Characteristics	Symbol			V _{CC} (V)	тур.	Onit
Input capacitance	C _{IN}	—		1.8, 2.5, 3.3	6	pF
Output capacitance	CO	—		1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

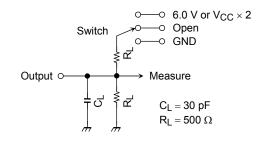
Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/20$ (per bit)

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AC Test Circuit



Parameter	Switch				
t _{pLH} , t _{pHL}	Open				
t _{pLZ} , t _{pZL}					
t _{pHZ} , t _{pZH}	GND				

Figure 1

AC Waveform

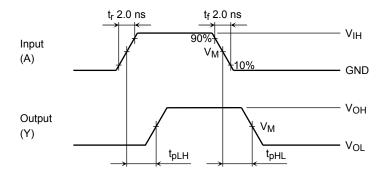


Figure 2 t_{pLH}, t_{pHL}

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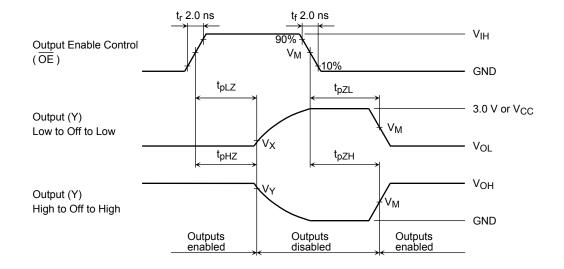
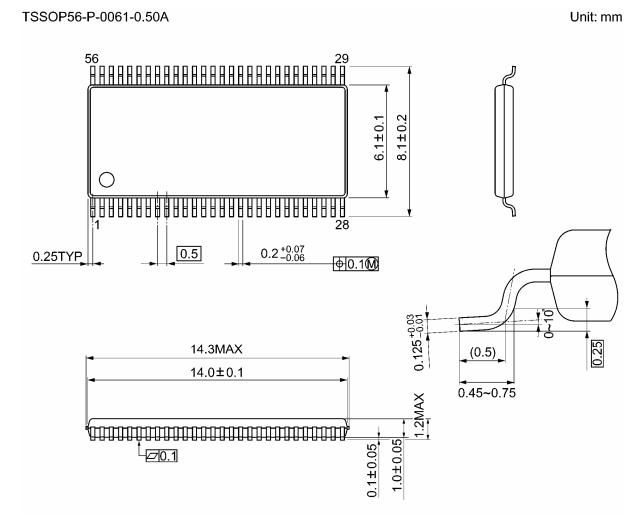


Figure 3	t _{pLZ} ,	t _{pHZ} ,	t _{pZL} ,	tpZH
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Symbol	V _{CC}		
	$3.3\pm0.3~V$	$2.5\pm0.2~\text{V}$	1.8 V
VIH	2.7 V	V _{CC}	V _{CC}
VM	1.5 V	V _{CC} /2	V _{CC} /2
VX	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V
VY	V _{OH} – 0.3 V	V _{OH} – 0.15 V	V _{OH} – 0.15 V

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Package Dimensions



Weight: 0.25 g (typ.)

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20070701-EN GENERAL

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